Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/699,937	UCHIDA ET AL.
Examiner	Art Unit
TAN V DINIU	2652

SEARCHED					
Class	Subclass	Date	Examiner		
×.					
			•		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
See the interference search report		7/25/2005	T.D		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (see the search report attached)	7/25/2005	T.D		
		·		
•				